


Search Notes 	Application/Control No. 10591664	Applicant(s)/Patent Under Reexamination FUKUOKA ET AL.
	Examiner BRENITRA M LEE	Art Unit 4176

SEARCHED			
Class	Subclass	Date	Examiner
313	484, 500, 503, 505, 506, 507, 512, 584, 586, 631	2/10/2009	BML

SEARCH NOTES		
Search Notes	Date	Examiner
Inspec, Inventor Name Search, IEEE Explore, Foreign Patent Search, East Search	2/10/2009	BML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/BRENITRA M. LEE/ Examiner, Art Unit 4176	
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